

<b>Notice of References Cited</b>	Application/Control No. 10/603,929	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Thanh T. Nguyen	Art Unit 2813	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,978,058	11-1999	Sung, Chae Gee	349/139
*	C	US-6,268,289	07-2001	Chowdhury et al.	438/687
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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